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RED-EMC Test Report

Client Name :

Address :

Product Name : Power Bank

Date : May 25, 2019



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TEST REPORT

Applicant :
Manufacturer :
Product Name :
Model No. :

Trade Mark

Micro USB Input: 5V== 2A

Type-C Input/Output: 5V== 3A

Rating(s) Output: 5V== 2.1A Total max. Output: 3A

Output: Wireless Charger 5W

Battery Capacity: 8000mAh/ 3.7V, 29.6Wh

Rated Capacity: 4800mAh/5V, 3A

Test Standard(s) : ETSI EN 301 489-1 V2.2.0 (2017-03)

EN 55032: 2015 EN 55035: 2017

ETSI EN 301 489-3 V2.1.1 (2017-03)

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the EN 301 489-1, EN 301 489-3 and EN 55032, EN 55035 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Receipt
Date of Test

May 14, 2019

May 14~24, 2019

Prepared By

(Engineer / Oliay Yang)

Reviewer

(Supervisor / Snowy Meng)

Approved & Authorized Signer

(Manager / Sally Zhang)



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1. General Information

1.1. Client Information

Y			10°	5/1.		160	- 10
Applicant	:		Vupp		46/4	- Above	P.
Address	:						
Manufacturer	:						,ter
Address	:	3					NDO.
Factory	:						
Address	:						(ek

1.2. Description of Device (EUT)

OV		0, 7, ,0,
:	Power Bank	
:	P68W, PB8W (Note: All samples are the prepare "P68W" for test	ne same except the model and appearance, so we only.)
:	Anbote,	
:	AC 230V, 50Hz for adap DC 3.7V battery inside	ter/ AC 110V, 50Hz for adapter/
:	1-2-1(Normal Sample), 1	-2-2(Engineering Sample)
	Operation Frequency:	110-205KHz
	Modulation Type:	MSK
•	Antenna Type:	Inductive loop coil Antenna
	Antenna Gain(Peak):	O dBi* Anbotek Anbotek Anbotek
	:	P68W, PB8W (Note: All samples are the prepare "P68W" for test AC 230V, 50Hz for adapted DC 3.7V battery inside 1-2-1(Normal Sample), 1 Operation Frequency: Modulation Type: Antenna Type:

Remark: 1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

1.3. Auxiliary Equipment Used During Test

2)-	Adapter	:	Model: A2013	Anbotek	Anbor	hotek	Anboren An
'n			Input: 100-240V 50-0	60Hz 0.7A			anbotek
			Output: 3.6-6.5V===	3A/ 6.5-9V==	= 2A/ 9-12V=	= 1.5A	, botek
			Anbotek Anbot	e. Yun	itek Anbot	ek Anbore	rek abotek
	Mobile Phone	:	iPhone	pote And	notek An	botek Anbo	rek prote





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1.4. Description of Test Modes

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

×3	Pretest Mode	Description
Anh	Mode 1	Wireless Charge Mode
3	Mode 2	Full Load

For Conducted Emission					
Final Test Mode Description					
Mode 1	Wireless Charge Mode				

	For Radiated Emission
Final Test Mode	Description
Mode 1	Wireless Charge Mode
Mode 2	Full Load

Note: The EUT was tested on (Mode 1, Mode 2) modes, only the Mode 2 was tested using EN 55032 and EN 55035 standards.



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1.5. Test Equipment List

Conducted Emission Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
nbîtek Nabot	L.I.S.N. Artificial Mains Network	Rohde & Schwarz	ENV216	100055	Nov. 26, 2018	1 Year
2.	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Nov. 05, 2018	1 Year
3.	RF Switching Unit	Compliance Direction	RSU-M2	38303	Nov. 05, 2018	1 Year
4. botek	Software Name EZ-EMC	Ferrari Technology	ANB-03A	N/A	N/A	N/A

Radiated Emission Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Nov. 05, 2018	1 Year
2.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	Nov. 19, 2018	1 Year
3.	Pre-amplifier	SONOMA	310N	186860	Nov. 05, 2018	1 Year
4.	Software Name EZ-EMC	Ferrari Technology	ANB-03A	N/A	N/A	N/A
5.	Preamplifier	SKET Electronic	BK1G18G30 D	KD17503	Nov. 05, 2018	1 Year
6.	Spectrum Analysis	Agilent	E4407B	US3939058 2	Nov. 05, 2018	1 Year
Anbote	Double Ridged Horn Antenna	Instruments corporation	GTH-0118	351600	Nov. 19, 2018	1 Year

Electrostatic Discharge Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
nb ^{ote} 1.	ESD Simulators	3Ctest	ESD-30T	ES0131505	Nov. 26, 2018	1 Year



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R/S Immunity Measurement

	initiality woodsaromone					
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1ek	Signal Generator	Agilent	N5182A	MY48180656	Nov. 05, 2018	1 Year
2 _{nb} o	Amplifier	Micotoop	MPA-80-1000 -250	MPA1903096	N/A	N/A
3 🗚	Amplifier	Micotoop	MPA-1000-60 00-100	MPA1903122	N/A	N/A
4	Log-Periodic Antenna	Schwarzbeck	VULP9118E	00992	Aug. 17, 2018	3 Year
5	Horn Antenna	Instruments corporation	GTH-0118	351600	Nov. 19, 2018	3 Year
6	Power Sensor	Agilent	E9301A	MY41498906	Nov. 05, 2018	1 Year
7	Power Sensor	Agilent	E9301A	MY41498088	Nov. 05, 2018	1 Year
8	Power Meter	Agilent	E4419B	GB40202909	Nov. 05, 2018	1 Year
9	Field Probe	ETS-Lindgren	HI-6006	00212747	Apr. 20, 2017	3 Year
10	software	EMtrace	EM 3	odek N/A Mpo	N/A	N/A

1.6. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 184111

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registed and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 184111, July 31, 2017.

ISED-Registration No.: 8058A-1

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A-1, June 13, 2016.

Test Location

Shenzhen Anbotek Compliance Laboratory Limited.

1/F, Building D, Sogood Science and Technology Park, Sanwei community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.518102







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1.7. Performance Criteria

1.7.1. For EMS Test:

- √ A: Normal performance within the specification limits;
- \sqrt{B} : Temporary degradation or loss of function or performance which is self-recoverable;
- √ C: Temporary degradation or loss of function or performance which requires operator intervention or system reset;
- $\sqrt{}$ D: Degradation or loss of function which is not recoverable due to damage of equipment (components) or software, or loss of data

Note: The manufacturer's specification may define effects on the EUT which may be considered insignificant, and therefore acceptable.

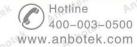
This classification may be used as a guide in formulating performance criteria, by committees responsible for generic, product and product-family standards, or as a framework for the agreement on performance criteria between the manufacturer and the purchaser, for example where no suitable generic, product or product-family standard exists.



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2. Summary of Test Results

	EMC Em	nission		
Test Items	Standard	Basic Standard	Limit	Results
Conducted Emission	ETSI EN 301 489-1 V2.2.0 Clause 8.3 & 8.4	EN 55032: 2015	Class B	PASS
Radiated Emission	ETSI EN 301 489-1 V2.2.0 Clause 8.2	EN 55032: 2015	Class B	PASS (%)
Harmonic Current Emission	ETSI EN 301 489-1 V2.2.0 Clause 8.5	EN 61000-3-2: 2014	Class A	N/A
Voltage Fluctuations& Flicker	ETSI EN 301 489-1 V2.2.0 Clause 8.6	EN 61000-3-3: 2013	/	N/A
	EMC Imn	nunity		
Test Items	Standard	Basic Standard	Performance Criteria	Results
Electrostatic Discharge	ETSI EN 301 489-1 V2.2.0 Clause 9.3	EN 61000-4-2: 2009	Anbotek B	PASS
RF Electromagnetic Field	ETSI EN 301 489-1 V2.2.0 Clause 9.2	EN 61000-4-3: 2006 +A1: 2008+A2: 2010	tek A Anbotek	PASS
Fast transients, common mode	ETSI EN 301 489-1 V2.2.0 Clause 9.4	EN 61000-4-4: 2012	ibotek B Anbo	N/A
Surges	ETSI EN 301 489-1 V2.2.0 Clause 9.8	EN 61000-4-5: 2014+A1: 2017	Ant B	N/A
Radio frequency, common mode	ETSI EN 301 489-1 V2.2.0 Clause 9.5	EN 61000-4-6: 2014	Lek Anbotek	N/A
Volt. Interruptions Volt. Dips	ETSI EN 301 489-1 V2.2.0 Clause 9.7	EN 61000-4-11: 2004	B/C/C NOTE (3)	N/A
NOTE:	botek Anboten Anbo	lek spotek	Anboto An	ntek.
(2) Alternatively, f telecommunica (3) Voltage dip: 10 Voltage dip: 10	test is not applicable in this or equipment intended to be ationcentre, the class A limits 00% reduction – Performance 00% reduction – Performance	used exclusively in an s may be used. e Criteria B e Criteria B	industrial envir	onment or a
920	% reduction – Performance	V	Anbotek Anb	io. Vi
Voltage Interru	ption: 0% Interruption – Perfo	ormance Criteria C	notek I	upole





3. Emission Test

3.1. Conducted Emission Test at Main Ports

3.1.1. Test Standard and Limit

Test Standard	ETSI EN 301 489-1 V2.2.0 Clause 8.3 & 8.4	
Basic Standard	EN 55032: 2015	

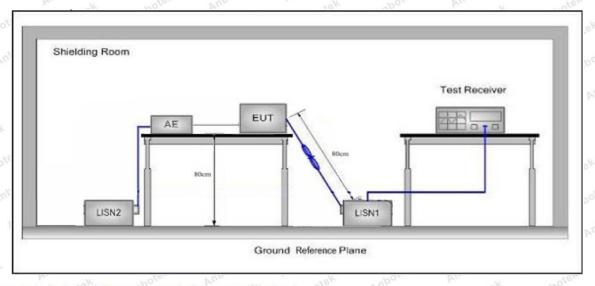
Limits for conducted emissions

101			by.
	Fraguenav	Maximum RF L	ine Voltage (dBuV)
Test Limit	Frequency	Quasi-peak Level	Average Level
	150kHz~500kHz	66 ~ 56 *	56 ~ 46 *
	500kHz~5MHz	56	46
	5MHz~30MHz	60	50
Remark: *Decreasi	ing linearly with logarithm	of the frequency.	Anbotek Anbox An

Limits for conducted emissions of equipment intended to be used in telecommunication centres and industrial environment

	Fraguenay	Maximum RF Line Voltage (dBuV)						
To at 1 insit	Frequency	Quasi-peak Level	Average Level					
Test Limit	150kHz~500kHz	Anbour 79	66					
	500kHz~30MHz	73	60					

3.1.2. Test Setup



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3.1.3. Test Procedure

The EUT system is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC line are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to ETSI EN 301 489-1 V2.2.0 & EN 55032: 2015 on Conducted Emission Measurement.

The bandwidth of test receiver (ESCI) set at 9kHz.

The frequency range from 150kHz to 30MHz is checked.

For the actual test configuration, please refer to the related Item EUT Test Photos.

3.1.4. Test Data

PASS

The EUT should be compliance to the limit of Class B

Only the worst case data was showed in the report, please to see the following pages



Conducted Emission Test Data

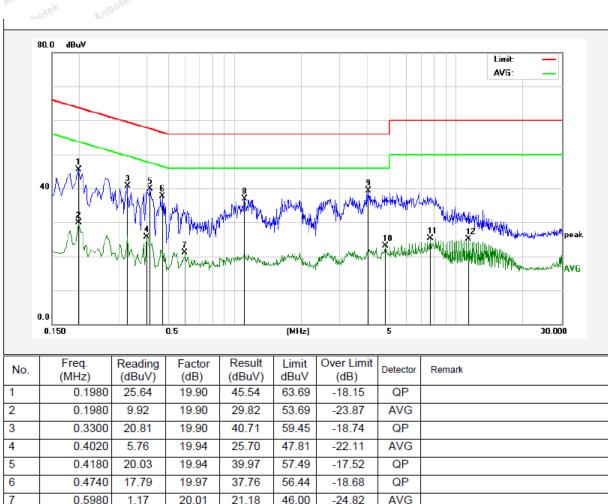
Test Site: 1# Shielded Room

Operating Condition: Mode 1

Test Specification: AC 230V, 50Hz for adapter

Comment: Live Line

Tem.: 21.7℃ Hum.: 54%



	(MHZ)	(aBuv)	(aB)	(aBuv)	aBuv	(aB)		
1	0.1980	25.64	19.90	45.54	63.69	-18.15	QP	
2	0.1980	9.92	19.90	29.82	53.69	-23.87	AVG	
3	0.3300	20.81	19.90	40.71	59.45	-18.74	QP	
4	0.4020	5.76	19.94	25.70	47.81	-22.11	AVG	
5	0.4180	20.03	19.94	39.97	57.49	-17.52	QP	
6	0.4740	17.79	19.97	37.76	56.44	-18.68	QP	
7	0.5980	1.17	20.01	21.18	46.00	-24.82	AVG	
8	1.1140	16.84	20.12	36.96	56.00	-19.04	QP	
9	4.0220	19.09	20.18	39.27	56.00	-16.73	QP	
10	4.8219	2.83	20.20	23.03	46.00	-22.97	AVG	
11	7.6699	4.96	20.28	25.24	50.00	-24.76	AVG	
12	11.3939	4.76	20.32	25.08	50.00	-24.92	AVG	



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Conducted Emission Test Data

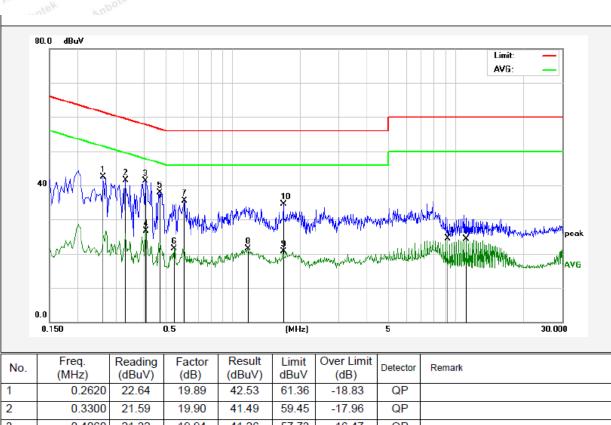
Test Site: 1# Shielded Room

Operating Condition: Mode 1

Test Specification: AC 230V, 50Hz for adapter

Comment: Neutral Line

Tem.: 21.7°C Hum.: 54%



ý	No.	(MHz)	(dBuV)	(dB)	(dBuV)	dBuV	(dB)	Detector	Remark
	1	0.2620	22.64	19.89	42.53	61.36	-18.83	QP	
	2	0.3300	21.59	19.90	41.49	59.45	-17.96	QP	
	3	0.4060	21.32	19.94	41.26	57.73	-16.47	QP	
	4	0.4100	6.73	19.94	26.67	47.65	-20.98	AVG	
	5	0.4700	17.92	19.97	37.89	56.51	-18.62	QP	
g	6	0.5460	1.44	19.99	21.43	46.00	-24.57	AVG	
	7	0.6060	15.56	20.01	35.57	56.00	-20.43	QP	
	8	1.1620	1.42	20.12	21.54	46.00	-24.46	AVG	
	9	1.6780	0.49	20.13	20.62	46.00	-25.38	AVG	
	10	1.6860	14.34	20.13	34.47	56.00	-21.53	QP	
	11	9.2020	4.22	20.32	24.54	50.00	-25.46	AVG	
	12	11.1740	4.00	20.32	24.32	50.00	-25.68	AVG	



Conducted Emission Test Data

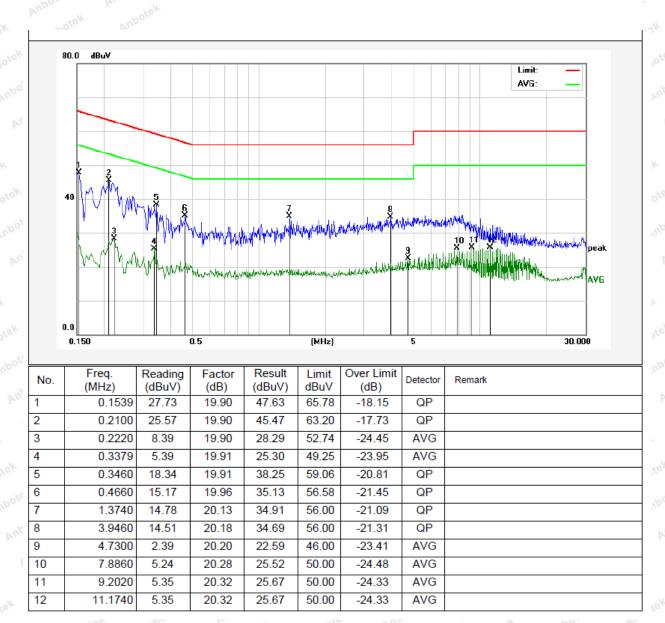
Test Site: 1# Shielded Room

Operating Condition: Mode 1

Test Specification: AC 110V, 50Hz for adapter

Comment: Live Line

Tem.: 21.7℃ Hum.: 54%



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Conducted Emission Test Data

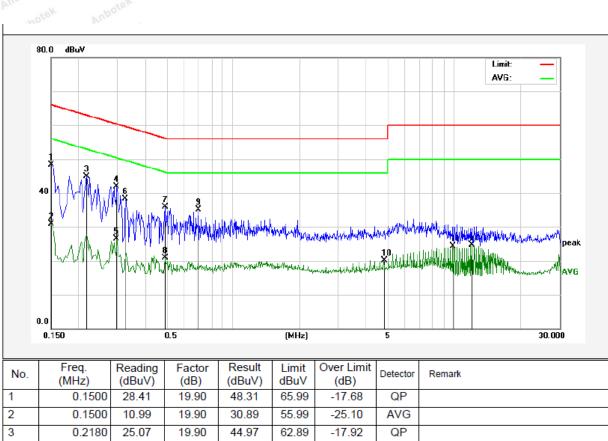
Test Site: 1# Shielded Room

Operating Condition: Mode 1

Test Specification: AC 110V, 50Hz for adapter

Comment: Neutral Line

Tem.: 21.7°C Hum.: 54%



	No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit dBuV	Over Limit (dB)	Detector	Remark
1		0.1500	28.41	19.90	48.31	65.99	-17.68	QP	
2		0.1500	10.99	19.90	30.89	55.99	-25.10	AVG	
3		0.2180	25.07	19.90	44.97	62.89	-17.92	QP	
4		0.2980	21.97	19.89	41.86	60.30	-18.44	QP	
5		0.2980	6.67	19.89	26.56	50.30	-23.74	AVG	
6	,	0.3260	18.41	19.90	38.31	59.55	-21.24	QP	
7	'	0.4940	15.83	19.98	35.81	56.10	-20.29	QP	
8		0.4940	0.86	19.98	20.84	46.10	-25.26	AVG	
9	1	0.6980	15.11	20.04	35.15	56.00	-20.85	QP	
1	0	4.8180	-0.16	20.20	20.04	46.00	-25.96	AVG	
1	1	9.8580	3.99	20.34	24.33	50.00	-25.67	AVG	
1	2	12.0500	4.44	20.31	24.75	50.00	-25.25	AVG	



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3.2. Radiated Emission Test

3.2.1. Test Standard and Limit

Test Standard	ETSI EN 301 489-1 V2.2.0 Clause 8.2	Aug	F-	-46/K	- upor	be
Basic Standard	EN 55032: 2015					

Radiated Emission Test Limit (Below 1000MHz)

611	•	1			
F	Limit (d	dBμV/m)			
Frequency (MHz)	Quasi-peak Level				
(IVII 12)	Class B	Class A			
30MHz~230MHz	40	50			
230MHz~1000MHz	47	57			
D WENT I WOOD					

Remark: 1. The lower limit shall apply at the transition frequency. 2. The test distance is 3m.

Radiated Emission Test Limit (Above 1000MHz)

F	Limit (dBμV/m)							
Frequency (MHz)	Clas	ss B	Class A					
(IVIFIZ)	Peak	Average	Peak	Average				
1000 MHz -3000 MHz	70	50	76	56				
3000 MHz -6000 MHz	boten 74 Ande	54	Anto 80	tek 60 botek				

Radiated Emission Test Limit for FM Receivers

Frequency (MHz)	Limit (dBμV/m)							
	Quasi-peak Level							
	Funda	amental	Н	armonics				
30MHz~230MHz	Noor Ar	60 Anbotes	VUD.	52	Anbore			
230MHz~300MHz	Anbore Am	60	Anbo	52	Anbor			
300MHz~1000MHz	Anbotes A	30 ,,,,,	otek Ambore	56	lns.			

Frequency Range of Radiated Measurement

Highest frequenc	y generated or U			
measurement used	in the device or	Range (MHz)		
ope	rates or tunes (M	lHz)		
Anbo Anbo	Below 108	Ann		1000
hotek Anbo	108 – 500	oter Anos		2000
abotek Anbote	500 – 1000	inbotek Anbo	,eK	5000
Anbotek Anbotek	Above 1000	Anbotek Anbo	botek	5th harmonic of the highest frequency or 6 GHz, whichever is lower





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3.2.2. Test Setup

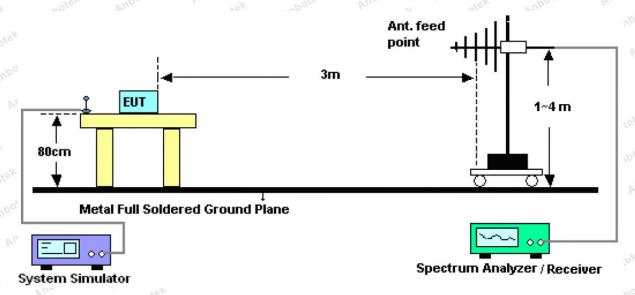


Figure 1. 30MHz to 1GHz

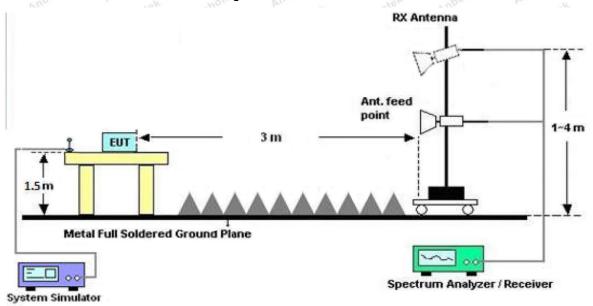


Figure 2. Above 1 GHz

3.2.3. Test Procedure

- 1) The measuring distance of at 3 m shall be used for measurements at frequency up to 1GHz. For frequencies above 1GHz, any suitable measuring distance may be used.
- 2) The EUT was placed on the top of a rotating table 0.1 meters above the ground at a 3 meter test site. The table was rotated 360 degrees to determine the position of the highest radiation.
- 3) The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.







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- 4) The initial step in collecting radiated emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured.
- 5) The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is below 1GHz.
- 6) The test receiver/spectrum was set to peak and average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1GHz.
- 7) For the actual test configuration, please refer to the related Item –EUT Test Photos.

Note:

The resolution bandwidth of test receiver/spectrum analyzer is 120kHz for Quasi-peak detection (QP) at frequency below 1GHz.

The resolution bandwidth is 1MHz and video bandwidth of test receiver/spectrum analyzer is 3MHz for Peak/ Average detection at frequency above 1GHz.

3.2.4. Test Data

PASS

The EUT should be compliance to the limit of Class B

Only the worst case data was showed in the report, please to see the following pages





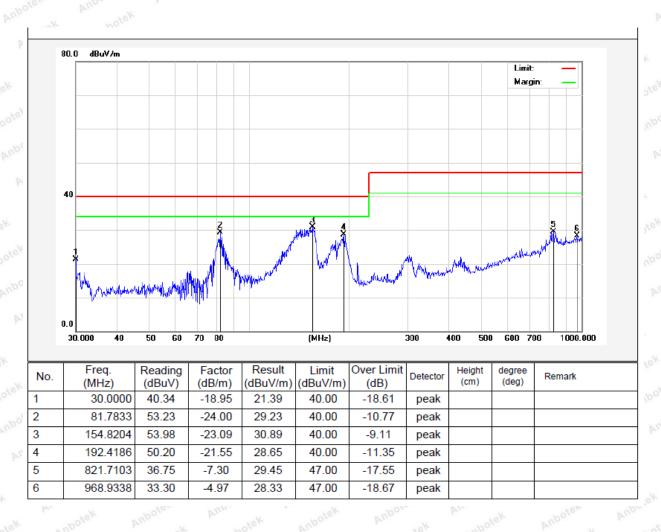
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Test Results (30~1000MHz)

Job No.: SZAWW190514001-01E Temp.(°C)/Hum.(%RH): 23.7°C/51%RH

Standard: EN301489_Class B_3m Power Source: DC 3.7V battery inside

Test Mode: Mode 2 Polarization: Horizontal





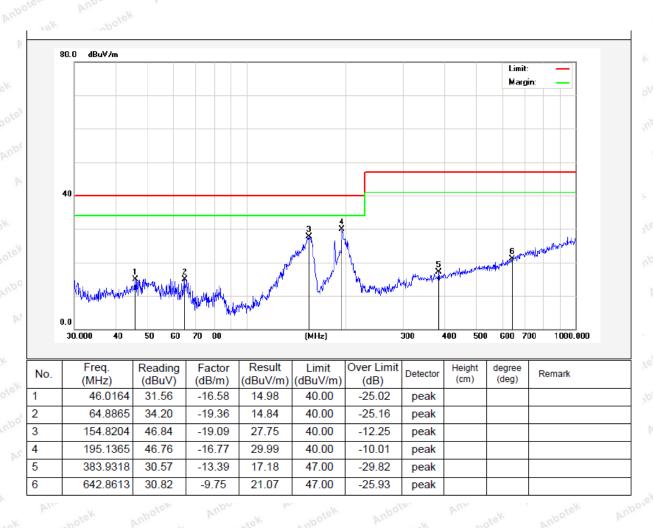
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Test Results (30~1000MHz)

Job No.: SZAWW190514001-01E Temp.(°C)/Hum.(%RH): 23.7°C/51%RH

Standard: EN301489_Class B_3m Power Source: DC 3.7V battery inside

Test Mode: Mode 2 Polarization: Vertical





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4. Immunity Test

General Performance Criteria

◆ Performance criteria for continuous phenomena applied to transmitters and receivers (CT/CR)

During and after the test, the apparatus shall continue to operate as intended. No degradation of performance or loss of function is allowed below a permissible performance level specified by the manufacturer when the apparatus is used as intended. In some cases this permissible performance level may be replaced by a permissible loss of performance.

During the test the EUT shall not unintentionally transmit or change its actual operating state and stored data.

If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be deduced from the product description and documentation and what the user may reasonably expect from the apparatus if used as intended.

Performance criteria for transient phenomena applied to transmitters and receivers (TT/TR)

After the test, the apparatus shall continue to operate as intended. No degradation of performance or loss of function is allowed below a permissible performance level specified by the manufacturer, when the apparatus is used as intended. In some cases this permissible performance level may be replaced by a permissible loss of performance.

During the EMC exposure to an electromagnetic phenomenon, a degradation of performance is, however, allowed. No change of the actual mode of operation (e.g. unintended transmission) or stored data is allowed.

If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be deduced from the product description and documentation and what the user may reasonably expect from the apparatus if used as intended.

◆ Performance criteria for equipment which does not provide a continuous communication link
For radio equipment which does not provide a continuous communication link, the performance criteria
described in CT/CR and TT/TR are not appropriate, then the manufacturer shall declare, for inclusion in
the test report, his own specification for an acceptable level of performance or degradation of
performance during and/or after the immunity tests.

The performance criteria specified by the manufacturer shall give the same degree of immunity protection as called for in CT/CR and TT/TR.

◆ Performance criteria for ancillary equipment tested on a stand alone basis

If ancillary equipment is intended to be tested on a stand alone basis, the performance criteria described in CT/CR and TT/TR are not appropriate, then the manufacturer shall declare, for inclusion in the test report, his own specification for an acceptable level of performance or degradation of performance during and/or after the immunity tests.

The performance criteria specified by the manufacturer shall give the same degree of immunity protection as called for in CT/CR and TT/TR.





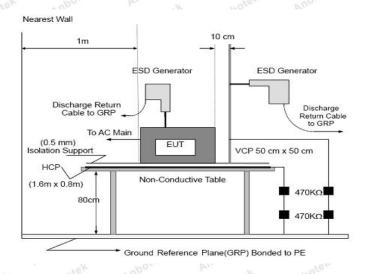
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4.1. Electrostatic Discharge Test

4.1.1. Test Standard and Specification

	M. P. L.	10° Di	- 0						
	Test Standard	ETSI EN 301 489-1 V2.2.0 Clause 9.3/ EN 55035 Clause 4.2.1							
	Basic Standard	EN 61000-4-2: 2009	,						
	Discharge Impedance	330 ohm / 150 pF	rek						
	Performance Criterion	CT/CR	1001						
₂ c C	D' 1 V 16	Air Discharge: 2kV/4kV/8kV	40						
	Discharge Voltage	Contact Discharge: 2kV/4kV (Direct/Indirect)	An						
	Polarity	Positive & Negative							
	Number of Discharge	Air Discharge: min. 20 times at each test point							
	Number of Discharge	Contact Discharge: min. 200 times in total	1ek						
	Discharge Mode	Single Discharge	noti						
	Discharge Period	1 second minimum	- X						
			-						

4.1.2. Test Setup



Note:

TABLE-TOP EQUIPMENT:

The GRP consisted of a wooden table 0.8 meters high standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the GRP by means of a cable with 940kohm total impedance. The equipment under test, was installed in a representative system as described in section 7 of IEC /EN 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5mm thickness. A distance of1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.







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FLOOR-STANDING EQUIPMENT:

The equipment under test was installed in a representative system as described in section 7 of IEC/EN 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.

4.1.3. Test Procedure

The test generator necessary to perform direct and indirect application of discharges to the EUT in the following manner:

1) Contact discharge was applied to conductive surfaces and coupling planes of the EUT.

During the test, it was performed with single discharges. For the single discharge time between successive single discharges was at least 1 second.

Vertical Coupling Plane (VCP):

The coupling plane, of dimensions 0.5m x 0.5m, is placed parallel to, and positioned at a distance 0.1m from, the EUT, with the Discharge Electrode touching the coupling plane.

The four faces of the EUT will be performed with electrostatic discharge.

Horizontal Coupling Plane (HCP):

The coupling plane is placed under to the EUT. The generator shall be positioned vertically at a distance of 0.1m from the EUT, with the Discharge Electrode touching the coupling plane.

The four faces of the EUT will be performed with electrostatic discharge.

Air discharges at insulation surfaces of the EUT.

It was at least ten single discharges with positive and negative at the same selected point.

- 3) When applying direct discharges to a portable or handheld battery-powered EUT with a display screen, it may not be possible to observe the screen for a given EUT orientation. If observation of the screen is necessary during this test, the EUT may be mounted vertically using non-metallic supports.
- 4) For the actual test configuration, please refer to the related Item –EUT Test Photos.





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4.1.4. Test Data

Job No.: SZAWW190514001-01E Temp.(℃)/Hum.(%RH): 24.3℃/55%RH

Standard: EN 61000-4-2 Power Source: AC 230V, 50Hz for adapter/

DC 3.7V battery inside

Test Mode: All Mode

Item	Contact Discharge to c	Air Discharge at insulating		
no	Direct Contact Discharge	Indirect Contact Discharge	surfaces	
Test Voltage	Reaction of EUT / Result	Reaction of EUT / Result	Reaction of EUT / Result	
+2kV	n.r.r. PASS	n.r.r. PASS	n.r.r. PASS	
-2kV	n.r.r. PASS	n.r.r. PASS	n.r.r. PASS	
+4kV	n.r.r. PASS	n.r.r. PASS	n.r.r. PASS	
-4kV	n.r.r. PASS	n.r.r. PASS	n.r.r. PASS	
+6kV	Inbotek Anbotek Anbo	otek Anbotek Anboten	n.r.r. PASS	
-6kV	Anbotek 100 A.	Anbotek Anbotes Anb	n.r.r. PASS	
+8kV	K Anbotek - Anboten	Anbotes Anbotek	n.r.r. PASS	
-8kV	otek Anbotek Anboten	Anbotek - Anbotek	n.r.r. PASS	

Remarks: n.r.r. = no reaction recognized

Performace Criteria B observed and No any function degraded during the tests.



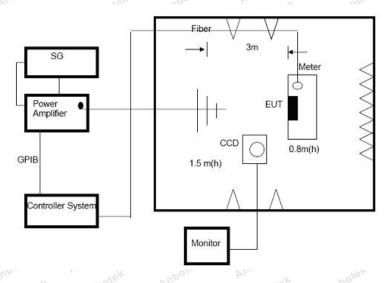
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4.2. Radiated, RF Electromagnetic Fields Test

4.2.1. Test Standard and Specification

Test Standard	ETSI EN 301 489-1 V2.2.0 Clause 9.2/ EN 55035 Clause 5				
Basic Standard	EN 61000-4-3: 2006+A1: 2008+A2: 2010				
Required Performance	A				
Frequency Range	80MHz to 6GHz				
Field Strength	3 V/m				
Modulation	1kHz Sine Wave, 80%, AM Modulation				
Frequency Step	1 % of preceding frequency value				
Polarity of Antenna	Horizontal and Vertical				
Test Distance	3 m				
Antenna Height	1.5 m Andrew Andrew Andrew Andrew Andrew Andrew				
Dwell Time	at least 0.5 seconds				
W. V.	1-0				

4.2.2. Test Setup



4.2.3. Test Procedure

The EUT and support equipment, which are placed on a table that is 0.1 meter above ground and the testing was performed in a fully-anechoic chamber. The testing distance from antenna to the EUT was 3 meters.

- 1) The field strength level was 3V/m
- 2) The frequency range is swept from 80 MHz to 6000 MHz with the signal 80%amplitude modulated with a 1kHz sine wave.





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3) The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond, but shall in no case be less than 0.5s.

4) The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

4.2.4. Test Data

Job No.: SZAWW190514001-01E Temp.(°C)/Hum.(%RH): 21.5°C/51.4%RH

Standard: EN 61000-4-3 Power Source: AC 230V, 50Hz for adapter/DC 3.7V battery inside

Test Mode: All Mode

Frequency Range (MHz)	Polarity	R.F. Field Strength	Azimuth	Result
ie, Yun	abotek Anbo	botek Anbotek An	Front	Anbotek Ant
90, 6000	Anboten Ar	3 V/m (rms) AM Modulated	Rear	-k hoter
abor Ali	tek aboten	1000Hz, 80%	Left	Ambotek Ambotek
ek Anbote An	Inbote	er abotek Anbo	Right	Anbotek Anbote
potek Anbotek	Anbotek Anbo		Anbotek Anbotek	Anbotek Anb
Anbotek Anbotek				botek Anboten
An abotek Anb				abote, Aug
ek Aupoter b				Anbotek Anb
botek Anboten	abotek An	potek Anbotek An	Anbotek Anboten	ek nbotek P



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APPENDIX I -- TEST SETUP PHOTOGRAPH

Photo of Conducted Emission Test



Photo of Radiation Emission Test





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Photo of Electrostatic Discharge Test



Photo of RF Field Strength Susceptibility Test



Shenzhen Anbotek Compliance Laboratory Limited

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APPENDIX II -- EXTERNAL PHOTOGRAPH





Shenzhen Anbotek Compliance Laboratory Limited

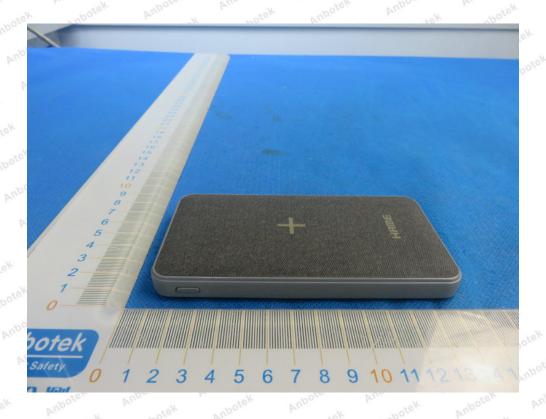
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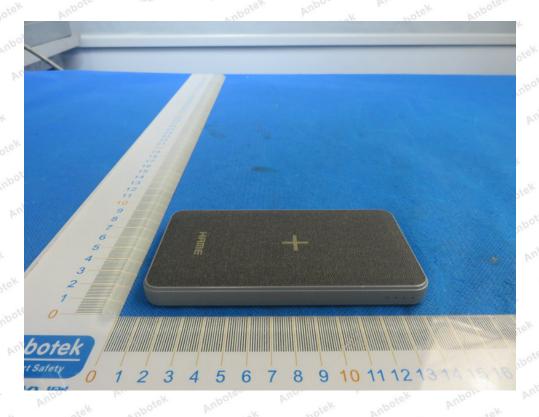
Tel:(86)755–26066440 Fax:(86)755–26014772 Email:service@anbotek.com





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APPENDIX III -- INTERNAL PHOTOGRAPH





Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.

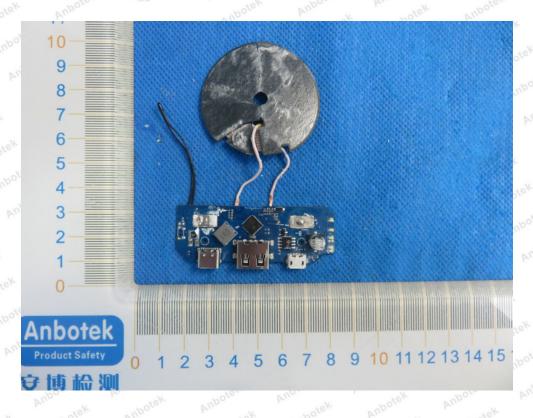
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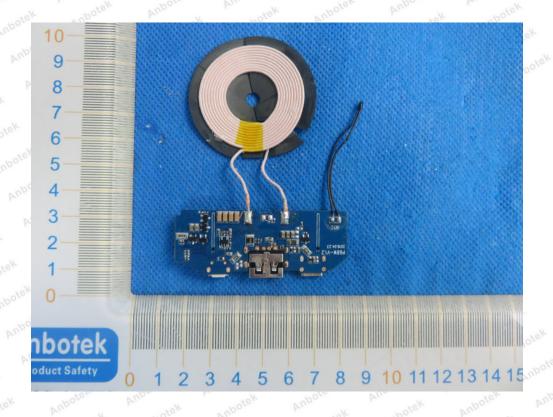
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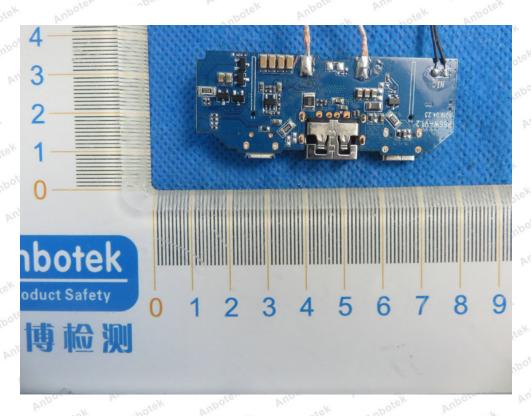






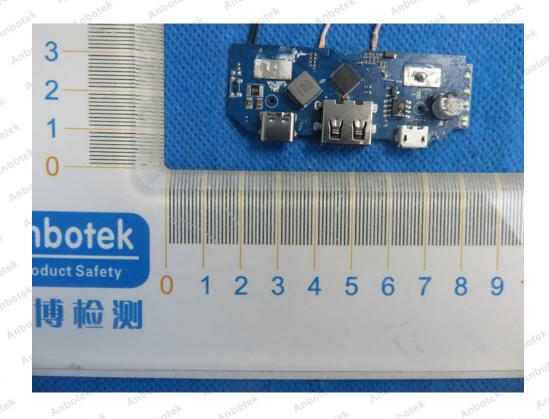
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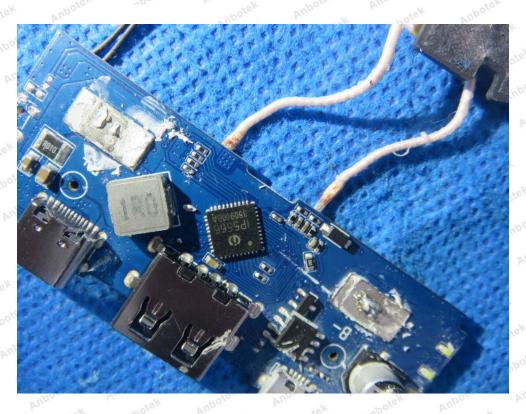






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----- End of Report -----